

# DEBUG IN HIGH DEFINITION



## HDO9000

1 GHz – 4 GHz Oscilloscopes



HD1024 Technology

**Superior User Experience** 

Powerful, Deep Toolbox

**Exceptional Serial Data Tools** 

The HDO9000 with HD1024 Technology provides exceptional signal fidelity with 10-bit resolution and a superior oscilloscope experience to deliver faster time to insight.

## **DEBUG IN HIGH DEFINITION**

High Definition Oscilloscopes with HD Technology have a variety of benefits that allow the user to debug in high definition. Waveforms displayed by High Definition Oscilloscopes are cleaner and crisper. More signal details can be seen and measured; these measurements are made with unmatched precision resulting in better test results and shorter debug time.





A critical element of the HDO9000 is HD1024 technology, which provides 10 bits of vertical resolution with 4 GHz bandwidth. As with all members of Teledyne LeCroy's HDO family, the HDO9000 utilizes an exceptionally low-noise system architecture that delivers outstanding effective number of bits (ENOB).

### **Dynamic ADC Reconfiguration**

HD1024 technology enables dynamic reconfiguration of the ADC to achieve 10 bits of vertical resolution. By automatically determining the best ADC configuration under each specific measurement condition, the HD09000 always provides the optimal resolution. The ADC can be set to 8, 9, or 10 bit configurations.

#### **HD Summary**

The HDO9000 conveniently displays an overview of the HD1024 operation which can be accessed via the HD descriptor box.

### **Optimized Filtering**

HD1024 high definition technology makes use of optimized filtering to provide additional resolution beyond 10-bits; extending up to 13.8 bits. When operating in low sample rate conditions, an anti-aliasing filter is automatically applied to reduce excess out-of-band noise. Additionally, resolution can be improved by applying a manual bandwidth limit on an individual channel.



	HDO4000	HD06000	HD08000	HDO9000
HD Technology	HD4096 12 bits	HD4096 12 bits	HD4096 12 bits	HD1024 10 bits
Bandwidth	200 MHz - 1 GHz	350 MHz - 1 GHz	350 MHz - 1 GHz	1 GHz - 4 GHz
Input Channels	2, 4	4	8	4
Sample Rate	2.5 GS/s	2.5 GS/s	2.5 GS/s	40 GS/s
Analysis Capability	Basic	Advanced	Advanced	Exceptional



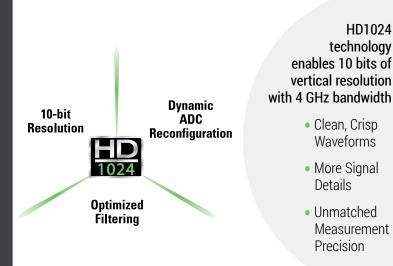
HD4096 high definition technology consists of high sample rate 12-bit ADCs, high signal-to-noise ratio amplifiers and a low-noise system architecture. This technology enables High Definition Oscilloscopes to capture and display signals of up to 1 GHz with high sample rate and 16 times more resolution than other oscilloscopes.



## DEBUG IN HIGH DEFINITION

HDO9000

# HD1024 High Definition Technology



Deep Toolbox



The HDO9000 with HD1024 Technology provides exceptional signal fidelity with 10-bit resolution and a superior oscilloscope experience to deliver faster time to insight.

Faster

Time to

Insight



Superior User Experience

3) Powerful, Deep Toolbox

Exceptional Serial Data Tools

Insight alone is not enough. Markets and technologies change too rapidly. The timing of critical design decisions is significant.

Faster Time to Insight is what matters.



## MAUI – SUPERIOR USER EXPERIENCE



## Designed for Touch

MAUI is designed for touch. Operate the oscilloscope just like a phone or tablet with the most unique touch screen features on any oscilloscope. All important controls are always one touch away. Touch the waveform to position or zoom in for more details using intuitive actions. MAUI – Most Advanced User Interface was developed to put all the power and capabilities of the modern oscilloscope right at your fingertips. Designed for touch; all important oscilloscope controls are accessed through the intuitive touch screen. Built for simplicity; time saving shortcuts and intuitive dialogs simplify setup. Made to solve; a deep set of debug and analysis tools helps identify problems and find solutions quickly.

## **Built for Simplicity**

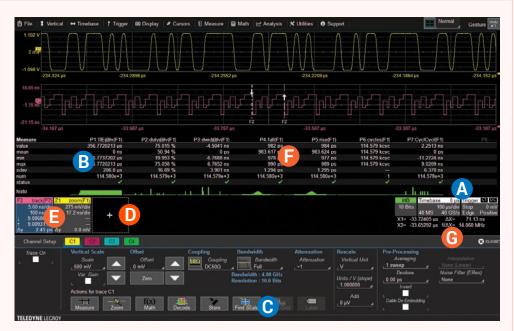
MAUI is built for simplicity. Basic waveform viewing and measurement tools as well as advanced math and analysis capabilities are seamlessly integrated in a single user interface. Time saving shortcuts and intuitive dialogs simplify setup and shorten debug time.

## Made to Solve

MAUI is made to solve. A deep set of integrated debug and analysis tools help identify problems and find solutions quickly. Unsurpassed integration provides critical flexibility when debugging. Solve problems fast with powerful analysis tools.

## MAUI with OneTouch

MAUI with OneTouch introduces a new paradigm for oscilloscope user experience. Dramatically reduce setup time with revolutionary drag and drop actions to copy and setup channels, math functions, and measurement parameters without lifting a finger. Use common gestures like drag, drop, and flick to instinctively interact with the oscilloscope. Quickly enable a new channel, math or measurement using the "Add New" button and simply turn off any trace or parameter with a flick of the finger. These OneTouch innovations provide unsurpassed efficiency in oscilloscope operation.



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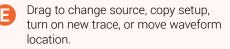
A Channel, timebase, and trigger descriptors provide easy access to controls without navigating menus.

B Configure parameters by touching measurement results.

С

Shortcuts to commonly used functions are displayed at the bottom of the channel, math and memory menus.

D Use the "Add New" button for one-touch trace creation.



Drag to quickly position cursors

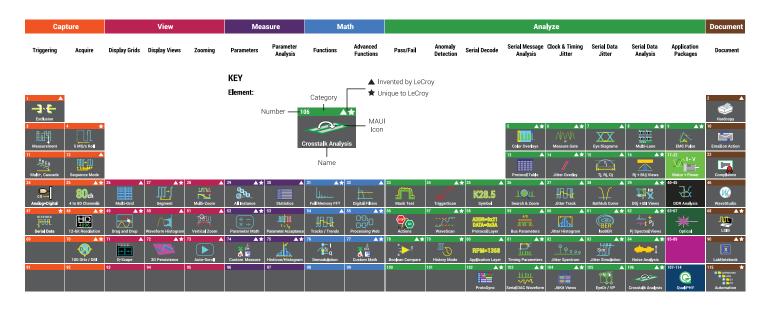
on a trace.

Drag to copy measurement parameters to streamline setup process.

MAUI 🛛 🛑 Unique to OneTouch

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## **POWERFUL, DEEP TOOLBOX**



# 17 A \* 19 A \* 20 A \* 22 A \* 63 64 \* 15 A \* 16 97 197 198 199 119 Image: Control Log Image: Controlog Image: Control Log <t

## Our Heritage

Teledyne LeCroy's 50+ year heritage has its origins in the high-speed collection of data in the field of highenergy physics, and the processing of long records to extract meaningful insight. We didn't invent the oscilloscope, but we did invent the digital oscilloscope, which can take full advantage of advanced digital signal processing and waveshape analysis tools to provide unparalleled insight.

## Our Obsession

Our developers are true to our heritage – they are more obsessed with making better and smarter tools than anybody else. Our tools and operating philosophy are standardized across much of our product line for a consistent user experience. Our mission is to help you use these tools to understand problems, including the ones you don't even know you have. Our deep toolbox inspires insight; and your moment of insight is our reward.

## **Our Invitation**

Our Periodic Table of Oscilloscope Tools provides a framework to understand the toolsets that Teledyne LeCroy has created and deployed in our oscilloscopes. Visit our interactive website to learn more about what we offer and how we can help you develop and debug more efficiently.

teledynelecroy.com/tools

## HDO9000 AT A GLANCE



HDO9000 High Definition Oscilloscopes leverage HD1024 technology to deliver 10 bits of resolution up to 4 GHz of bandwidth. HD1024 technology ensures that optimal resolution is always provided under each measurement condition for exceptional signal fidelity. The integration of a large, bright 15.4" capacitive touch screen and the MAUI with OneTouch user interface results in an unsurpassed user experience. Equipped with a 40 GS/s sample rate and an extensive toolbox the HDO9000 debugs in high definition to provide uncompromised measurement performance.

### **Key Features**

10 bit resolution; up to 13.8 bits with Optimized Filtering

1 GHz - 4 GHz bandwidths

Up to 40 GS/s sample rate

#### 15.4" capacitive touch screen

#### **MAUI with OneTouch**

- Designed for touch
- Built for simplicity
- Made to solve

#### **Advanced Tools**

- Jitter and Timing Analysis Capabilities
- WaveScan Search and Find
- LabNotebook Documentation
   and Report Generation
- History Mode Waveform Playback

#### **Optional Software Packages**

- Advanced Customization
- Digital Filtering
- Spectrum Analysis
- Device and Switching Power Supply Analysis
- Comprehensive set of serial data analysis, debug, validation and compliance tools

#### 16 digital channels with 1.25 GS/s

- Analog and Digital
   Cross-Pattern Triggering
- Digital Pattern Search and Find
- Analog and Digital Timing Measurements
- Logic Gate Emulation
- Activity Indicators



## HD1024 Technology

HD1024 high definition technology enables 10 bits of vertical resolution with 4 GHz bandwidth. The HD09000 automatically and dynamically determines the best ADC configuration under each specific measurement condition to always provide the optimal resolution.

## **Powerful, Deep Toolbox**

The standard collection of math, measurement, debug, and documentation tools provides unsurpassed analysis capabilities. Application-specific packages enable streamlined debugging for common design/validation scenarios. The advanced customization option (XDEV) enables user-defined parameters and math functions providing unique and limitless analysis capability.

### 15.4" Capacitive Touch Screen

The HDO9000 and MAUI with OneTouch allows users to perform all common operations with a single touch of the display, optimizing for convenience and efficiency. Meanwhile, the 15.4" high resolution capacitive touch screen's bright display and quick responsiveness further enhances the inherent efficiency and intuitiveness of MAUI with OneTouch.

## **Exceptional Serial Data Tools**

A wide a variety of application packages are available to meet all serial data test challenges, ranging from automated compliance packages to flexible debug toolkits. A suite of protocol specific measurement and eye diagram packages are available to complement the industry's most intuitive trigger and decode packages.





### **Key Attributes**

- 1. 15.4" high resolution WXGA capacitive touch screen display
- MAUI with OneTouch user interface optimized for convenience and efficiency
- 3. "Add New" button for fast waveform creation
- 4. HD1024 technology provides 10-bit resolution up to 4 GHz
- 5. Serial trigger captures signals up to 3 Gb/s
- "Push" Knobs All knobs have push functionality that provide shortcuts to common actions such as Set to Variable, Find Trigger Level, Zero Offset, and Zero Delay

- Waveform Control Knobs Control channel, zoom, math and memory traces with the multiplexed vertical and horizontal knobs
- Dedicated Cursor Knob Select type of cursor, position them on your signal, and read values without ever opening a menu
- Dedicated buttons to quickly access popular debug tools.
- Mixed Signal Capability Debug complex embedded designs with integrated 16 channel mixed signal capability

- **11.** Reference Clock Input/Output connectors for connecting to other equipment
- **12.** Easy connectivity with four USB 3.1 ports and three USB 2.0 ports
- USBTMC (Test and Measurement Class) over USB 3.1 for fast data offload



## **POWERFUL MIXED SIGNAL CAPABILITIES**



The HDO9000 High Definition Oscilloscopes offer powerful mixed signal solutions that combine high definition analog channels with the flexibility of digital inputs. The HDO9000-MS models are equipped with an integrated 16 digital channels and a 1.25 GS/s sampling rate which creates an all-in-one debug machine.

## Integrated 16-Channel Mixed Signal Capability

With embedded systems growing more complex, powerful mixed signal debug capabilities are an essential part of modern oscilloscopes. The 16 integrated digital channels and set of tools designed to view, measure and analyze analog and digital signals enable fast debugging of mixed signal designs.

### **Advanced Digital Debug Tools**

Using the powerful parallel pattern search capability of WaveScan, patterns across many digital lines can be isolated and analyzed. Identified patterns are presented in a table with timestamp information and enables quick searching for each pattern occurrence.

Use a variety of the many timing parameters to measure and analyze the characteristics of digital busses. Powerful tools like tracks, trends, statistics and histicons provide additional insight and help find anomalies. Quickly see the state of all the digital lines at the same time using convenient activity indicators.

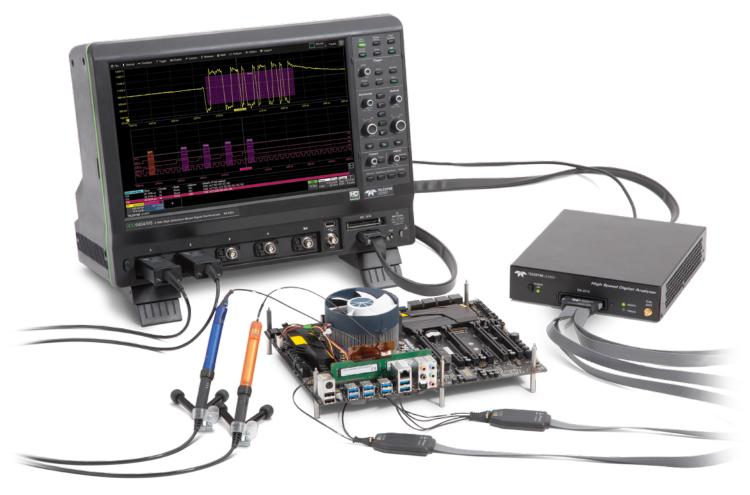
Simulate complete digital designs using logic gate emulation. When used with the web editor, many logic gates can be combined together in one math function to simulate complex logic designs. Choose from AND, OR, NAND, NOR, XOR, NOT and D Flip Flop gates.

### **Extensive Triggering**

Flexible analog and digital cross-pattern triggering across all 20 channels provides the ability to quickly identify and isolate problems in an embedded system. Event triggering can be configured to arm on an analog signal and trigger on a digital pattern.







For applications demanding even higher-performance mixed-signal acquisition capabilities, the HDA125 High-speed Digital Analyzer can be easily added to the HDO9000. With 12.5 GS/s digital sampling rate on 18 input channels and the revolutionary QuickLink probing solution, validation of challenging interfaces such as DDR memory has never been simpler or more comprehensive.

### Ultimate Mixed-signal Performance

With industry-leading sensitivity and a sample time of 80 ps per point, the HDA125 can accurately acquire and display digital signals up to 6 Gb/s. Combined with superior probe tip impedance (110 k $\Omega$ , 0.12pF differential), for minimal signal loading, the result is the highest-fidelity digital signal acquisition system available.

### Unique Probing Solution

One of the most challenging aspects of high-speed embedded test is simply getting the signals from the system under test to the instrumentation with sufficient fidelity. The HDA125 is built around Teledyne LeCroy's revolutionary QuickLink probing concept - enabling high signal quality, easy access to remote test points, and simple transitions from digital to analog probing.

### **Enhanced DDR Debug**

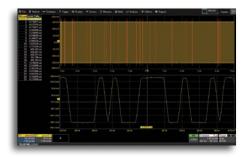
Teledyne LeCroy already offers the industry's only dedicated DDR Debug Toolkit, designed to simplify challenging memory interface validation. Adding the HDA125 allows the DDR command bus to be directly acquired and integrated into the analysis, enabling advanced command triggering and sophisticated, searchable bus state viewing.

## **ADVANCED TOOLS FOR WAVEFORM ANALYSIS**



Isolate events using the serial bus trigger and view color-coded protocol information on top of analog or digital waveforms. Timing and bus measurements allow quick and easy characterization of a serial data system. Serial (digital) data can be extracted and graphed to monitor system performance over time. Identify physical layer anomalies with eye diagram mask testing and mask failure locator.



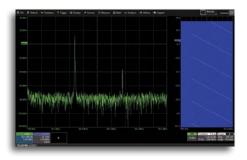


### WaveScan Advanced Search and Find Tool

Quickly scan analog, digital or parallel bus signals for runts, glitches or other anomalies with WaveScan.



**Jitter and Timing Analysis** Understand system jitter performance of clock and data signals. Enable histograms, tracks, and spectrum plots to visualize the data.



**Spectrum Analyzer Mode** View signal details in the frequency domain with a spectrum analyzer style user interface.

### **Sequence Mode Acquisition**

Capture many fast pulses in quick succession or events separated by long periods of time.

### History Mode Waveform Playback

Scroll back in time to isolate anomalies that have previously been captured to quickly find the source of the problem.

## LabNotebook Documentation and Report Generation Tool

Save all results and data with a single button press and create custom reports with LabNotebook.





Use two independent input settings and frequency ranges for advanced spectrum analysis.

### Spectrum Analyzer Option (HDO9K-SPECTRUM)

The Spectrum Analyzer mode provides a spectrum analyzer style user interface with controls for start/stop frequency or center frequency and span. The resolution bandwidth is automatically set for best analysis or can be manually selected. Vertical Scale can be selected in the desired units and the unique peak search automatically labels spectral components and presents frequency and level in an interactive table. To monitor how the spectrum changes over time, view the spectrogram which can display a 2D or 3D history of the frequency content.



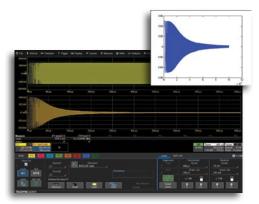
## Power Analyzer Software Option (HDO9K-PWR)

Quickly measure and analyze operating characteristics of power conversion circuits. Make automatic switching device measurements and identify areas of loss and conduction with color-coded overlay. Control loop modulation analysis and line power harmonic testing are all simplified with a dedicated user interface.



## Digital Filter Software Option (HDO9K-DFP2)

DFP2 lets you implement Finite Impulse Response (FIR) or Infinite Impulse Response (IIR) filters to eliminate undesired spectral components, such as noise, and enhances your ability to examine important signal components. You can choose from a standard set of FIR or IIR filters or you can also design your own custom filters. Create and apply a variety of FIR and IIR digital filters to your capture waveforms or processed traces.



## XDEV Advanced Customization Option (HDO9K-XDEV)

With the XDEV option, third party programs can be completely integrated into the oscilloscope's processing stream. Create customized math functions and parameters using C/C++, MATLAB, Excel, JScript or Visual Basic without ever leaving the oscilloscope application - and view the results directly on the oscilloscope, in real-time.





## WaveScan Advanced Search

WaveScan provides powerful isolation capabilities that hardware triggers can't provide. WaveScan allows searching analog, digital or parallel bus signal in a single acquisition using more than 20 different criteria. Or, set up a scan condition and scan for an event over hours or even days.

Since the scanning "modes" are not simply copies of the hardware triggers, the utility and capability is much higher. For instance, there is no "frequency" trigger in any oscilloscope, yet WaveScan allows for "frequency" to be quickly "scanned." This allows the user to accumulate a data set of unusual events that are separated by hours or days, enabling faster debugging.

When used in multiple acquisitions, WaveScan builds on the traditional Teledyne LeCroy strength of fast processing of data. Quickly scan millions of events looking for unusual occurrences, and do it much faster and more efficiently than other oscilloscopes can. Found events can be overlaid with the ScanOverlay to provide a quick comparison of events; measurement based scans populate the ScanHistogram to show the statistical distribution of the events.

Additionally, digital lines can be used as inputs into WaveScan to isolate and analyze patterns using the powerful parallel pattern search capability. Identified patterns are presented in a table with timestamp information and enables quick searching for each pattern occurrence.

## Advanced Waveform Capture with Sequence Mode

Use Sequence mode to store up to 15,000 triggered events as "segments" into memory. This can be ideal when capturing many fast pulses in quick succession or when capturing events separated by long time periods, such as bursted serial data packets. Sequence mode provides timestamps for each acquisition and minimizes dead-time between triggers to less than 1 µs. Combine Sequence mode with serial triggers and decode to optimize the oscilloscope's memory usage.

### **Advanced Math and Measure**

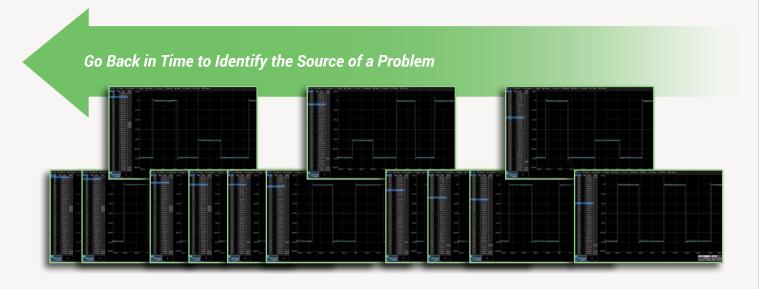
With many math functions and measurement parameters available, the HDO9000 can measure and analyze every aspect of analog and digital waveforms. Beyond just measuring waveforms, the HDO9000 provides statistics, histicons, tracks and trends to show how waveforms change over time. Measurements and math functions can be quickly copy and setup using MAUI with OneTouch.





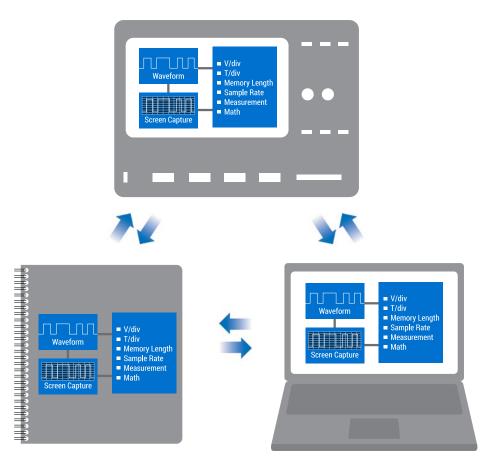
## **History Mode Waveform Playback**

Scroll back in time using History Mode to view previous waveforms and isolate anomalies. Use cursors and measurement parameters to quickly find the source of problems. History mode is always available with a single button press, no need to enable this mode and never miss a waveform.



### LabNotebook

The LabNotebook feature of HD09000 is the ideal documentation tool. LabNotebook automatically saves all displayed waveforms, oscilloscope setup file, and a screen with a single button press, eliminating the need to navigate multiple menus to save all these files independently. Report files can be annotated and shared with colleagues to fully document all results. Easily recreate experiments and compare tests results amongst colleagues across the world by recalling LabNotebook files back onto the oscilloscope or view on a PC using WaveStudio.



## MOST COMPLETE SERIAL DATA DEBUG AND VALIDATION

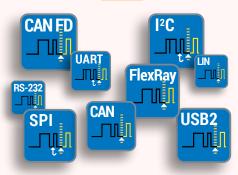
The HDO9000 features the widest range and most complete serial data debug and validation solutions.

- Triggering
- Decoding
- Measurement and Graphing
- Eye Diagram and Physical Layer Analysis

Various compliance test, synchronized protocol decode views, and other advanced jitter analysis tools are also available.

### Solutions address the following markets and applications:

- Embedded Computing
- Automotive
- Industrial
- Military and Avionics
- Peripherals
- Memory
- Handset/Mobile/Cellular
- High Speed Computing
- Data Storage
- Serial Digital Audio

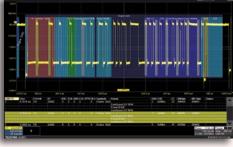


### Trigger

Powerful, flexible triggers designed by people who know the standards, with the unique capabilities you want to isolate unusual events. Conditional data triggering permits maximum flexibility and highly adaptable error frame triggering is available to isolate error conditions. Efficiently acquire bursted data using Sequence Mode to maximize the oscilloscope's memory usage. Sequence Mode enables the oscilloscope to ignore idle time and acquire only data of interest.







### Decode

Decoded protocol information is colorcoded to specific portions of the serial data waveform and transparently overlaid for an intuitive, easy-tounderstand visual record. All decoded protocols are displayed in a single time-interleaved table. Touch a row in the interactive table to quickly zoom to a packet of interest and select a column header to create filter criteria, as is commonly done in spreadsheets. Easily search through long records for specific protocol events using the builtin search feature.

### **ProtoSync**

ProtoSync combines the oscilloscope view with a simultaneous view of data link layer decodes on the same instrument. This combination makes ProtoSync very effective in debugging protocol-specific negotiation rates.

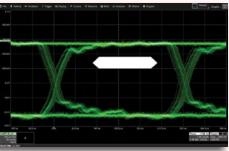
Compatible with PCI Express, USB 2.0, USB2-HSIC, SAS, SATA, and Fibre Channel.





#### Measure/Graph

Quickly validate cause and effect with automated timing measurements to or from an analog signal or another serial message. Make multiple measurements in a single long acquisition to quickly acquire statistics during cornercase testing. Serial (digital) data can be extracted to an analog value and graphed to monitor system performance over time, as if it was probed directly. Complete validation faster and gain better insight.



### **Eye Diagram**

Rapidly display an eye diagram of your packetized low-speed serial data signal without additional setup time. Use eye parameters to quantify system performance and apply a standard or custom mask to identify anomalies. Mask failures can be indicated and can force the scope into Stop mode.

SDAII or DDR Debug (optional) create eye diagrams of streaming NRZ serial data or DDR signals, and measure and analyze jitter breakdown.

### **QualiPHY / Compliance**

Compliance testing is a critical part of the design cycle in order to ensure that requirements are met. The QualiPHY framework provides an automated and easy-to-use compliance testing platform for a number of serial data standards.



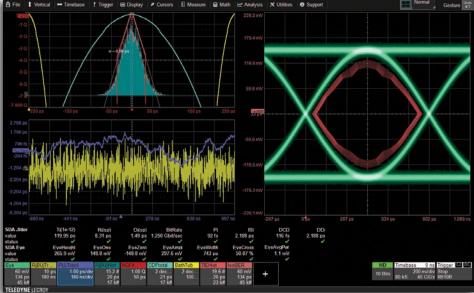
:	HDO9000 Serial Data Protocol Support	Trigger	Decode	Measure/Growt	Eye Diagram	ProtoSync	QualipHy
	l <sup>2</sup> C	•					
Embedded Computing	SPI	•			•		
omp	UART-RS232	•			•		
шо	USB2-HSIC						
	CAN	•			•		
strial	CAN FD	•					
snpu	FlexRay	•			•		
e+	LIN	•			•		
notiv	SENT						
Automotive + Industrial	MOST50/150						•
	BroadR-Reach						•
s	ARINC429						
Avionics	MIL-STD-1553	•			•		
Ą	SPACEWIRE		•				
	Ethernet						
_	(10/100Base-T) Ethernet	$\square$					
uting erals	(1000Base-T)						•
ompi	USB 2.0	•	•	•	•	•	•
High Speed Computing, Storage +Peripherals	8b/10b	•	•		•		
Spe	Fibre Channel		•				
High	SATA (1.5 & 3 Gb/s)	•	•			•	
	SAS (1.5 & 3 Gb/s)		•			•	
	PCI Express (Gen1)		•			•	
ory	LPDDR2				•		•
demory	DDR2				•		•
2	DDR3				•		•
	D-PHY/CSI-2/DSI		•		•		•
_	DigRF3G		•	•			
MIPI	DigRFv4						
	UniPro						
	M-PHY						
اير	Audio (I <sup>2</sup> S, LJ, RJ, TDM)	•					
Other	Manchester						
	NRZ	•					

## **MOST COMPLETE SERIAL DATA DEBUG & VALIDATION**



### SDA II – Advanced Tools to Isolate and Analyze (HDO9K-SDAII)

Unleash the power of serial data analysis for understanding and characterizing a design, proving compliance, and understanding why a device or host fails compliance. The SDAII architecture provides fast updates and eye diagram creation. Combined with up to 128 Mpts record lengths and more complete jitter decomposition tools, SDA II provides a fast and complete understanding of why serial data fails a compliance test. Whether debugging eye pattern or other compliance test failures, the HDO9000 Oscilloscopes rapidly isolate the source of the problem.



Advanced jitter decomposition methodologies and tools provide more information about root cause. Tj Analysis, RjBUj Analysis and DDj Analysis are made simple with the deepest toolset dedicated to providing the highest level of insight into your serial data signals.

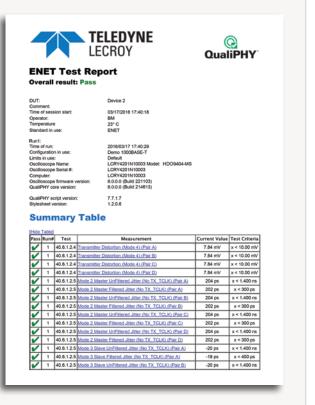
## QualiPHY

QualiPHY is designed to reduce the time, effort, and specialized knowledge needed to perform compliance testing on high-speed serial buses.

- Guides the user through each test setup
- Performs each measurement in accordance with the relevant test procedure
- Compares each measured value with the applicable specification limits
- Fully documents all results
- QualiPHY helps the user perform testing the right way every time

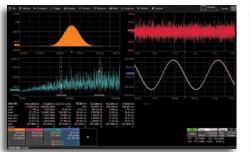
#### Supported Standards:

- ENET
- USB
- DDR2, DDR3, LPDDR2
- MIPI-DPHY
- BroadR-Reach
- MOST50, MOST150



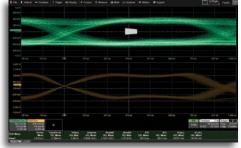
*Compliance Reports contain all of the tested values, the specific test limits and screen captures. Compliance Reports can be created as HTML, PDF or XML.* 





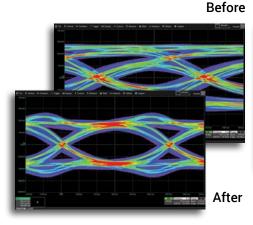
## Jitter and Timing Analysis Option (HDO9K-JITKIT)

JITKIT makes it simple and easy to understand the basic system jitter performance of clock signals and clock-data activities, including period, half period, cycle-cycle, skew, amplitude, differential voltage crossing, slew rate, and a wide variety of other common jitter measurements.



## DDR Debug Toolkit (HDO9K-DDR3-Toolkit)

The DDR Debug Toolkit provides test, debug and analysis tools for the entire DDR design cycle. The unique DDR analysis capabilities provide automatic Read and Write burst separation, bursted data jitter analysis and DDR-specific measurement parameters. The HDO9000 supports both standard and custom speed grades of DDR2 and DDR3.



## Eye Doctor II (HDO9K-EYEDRII)

The Eye Doctor II advanced signal integrity toolkit enables a complete set of channel emulation, de-embedding, and receiver equalization simulation tools. It provides capability to emulate a serial data link, de-embed or embed a fixture, cable or serial data channel, add or remove emphasis, and perform CTLE, FFE, or DFE equalization.

### Q-Scape Multi-tab Display Architecture (HDO9K-Q-SCAPE)

Unique Q-Scape multitab display architecture speeds up your understanding of your design with 4x the display area. Acquired or calculated waveforms can be located on any of four different "tabbed" oscilloscope grid displays, with individually selectable grid styles available for each tab. Quickly move waveforms to different tabs through drag-and-drop.

## **Advanced Probe Interface**

The advanced active probe interface gives tremendous flexibility for measuring high voltages, high frequencies, currents, or differential signals.

#### **High Impedance Active Probes**



#### High Bandwidth Differential Probes



#### High Voltage Differential Probes



#### **High Voltage Passive Probes**



#### **Current Probes**



Interpolation

Envelope (Extrema)

				102	
				1024	
	HD09104	HD09204	HD09304	HD09404	
Vertical Angles Chemical	HDO9104-MS	HD09204-MS	HD09304-MS	HD09404-MS	
<u>Vertical - Analog Channels</u> Analog Bandwidth @ 50 Ω (-3 dB)	1 GHz	2 GHz	3 GHz	4 GHz	
	(≥ 2 mV/div)	(≥ 5 mV/div)	(≥ 5 mV/div)	(≥ 5 mV/div)	
Analog Bandwidth @ 1 M $\Omega$ (-3 dB) *	1 GHz (typical)	1 GHz (typical)	1 GHz (typical)	1 GHz (typical)	
Rise Time (10–90%, 50 Ω)	415 ps	200 ps	134 ps	100 ps	
. ,	(typical)	(typical)	(typical)	(typical)	
Rise Time (20–80%, 50 $\Omega$ )	290 ps (typical)	146 ps (typical)	98 ps (typical)	75 ps (typical)	
Input Channels	4		(typiotit)	(typical)	
Vertical Resolution	10 bits; up to 13.8 bits with (				
Effective Number of Bits (ENOB) $\dagger **$ Vertical Noise Floor (rms, 50 $\Omega$ ) $\dagger$	7.9 bits	7.4 bits	7.0 bits	6.8 bits	
1 mV/div	160 µV	160 µV	160 µV	160 µV	
2 mV/div	160 µV	160 μV 160 μV	160 μV 160 μV	160 µV	
5 mV/div	175 µV	225 µV	280 µV	317 µV	
10 mV/div	184 µV	239 µV	295 µV	342 µV	
20 mV/div	257 µV	<u>351 µV</u>	<u>437 μV</u>	509 µV	
50 mV/div	435 µV	600 μV	743 μV	<u>859 μV</u>	
<u>100 mV/div</u> 200 mV/div	<u>761 μV</u> 2.73 mV	<u>1.05 mV</u> 3.64 mV	1.28 mV 4.53 mV	<u>1.48 mV</u> 5.15 mV	
	4.67 mV	5.98 mV	7.36 mV	8.37 mV	
1 V/div	7.79 mV	10.8 mV	13.1 mV	14.9 mV	
Sensitivity		variable; <b>1 M</b> Ω: 1 mV/div–1	0 V/div, fully variable		
DC Vertical Gain Accuracy	±1% F.S. (typical), offset at 0	V			
(Gain Component of DC Accuracy)	100.1				
Channel-Channel Isolation Offset Range	> 100:1 up to ra	ated BW (typical)	<u>DC -2.5 GHZ: &gt;100:1; 2.5 GH</u> Ω:	z to rated BW: >30:1 (typical)	
Onset Range			≤ 1 GHz		
			liv, ±4 V @ 5 mV–9.9 mV/div,		
		±8 V @ 10 mV-19.8 mV/c	div, ±10 V @ 20 mV−1 V/div		
	BWL > 1 GHz				
	±1.4 V @ 5 mV-100 mV/div, ±10 V @ 102 mV-1 V/div				
	<b>1 ΜΩ:</b> ±1.6 V @ 1 mV-4.95 mV/div, ±4 V @ 5 mV-9.9 mV/div,				
	±1.6 V @ 1 mV=4.95 mV/div, ±4 V @ 5 mV=9.9 mV/div, ±8 V @ 10 mV=19.8 mV/div, ±16 V @ 20 mV=140 mV/div,				
		<u>±80 V @ 142 mV-1.4 V/di</u>	v, ±160 V @ 1.42 V-10 V/div		
DC Vertical Offset Accuracy		of full scale + 1 mV) (test lim	lit)		
Maximum Input Voltage		$\Omega$ : 400 V max. (DC + peak AC	< 10 kHz)		
Input Coupling	<u>1 MΩ: AC, DC, GND; 50 Ω: D(</u>				
Input Impedance Bandwidth Limiters	20  MHz.	) MΩ    9.5 pF with supplied F 20 MHz,	20 MHz,	20 MHz,	
Danuwiutit Littiters	200 MHz, 500 MHz	200 MHz, 500 MHz,	200 MHz, 500 MHz,	200 MHz, 500 MHz,	
	,	1 GHz	1 GHz, 2 GHz	1 GHz, 2 GHz, 3 GHz	
Horizontal - Analog Channels					
Timebases	Internal timehase common t	o 4 input channels: an extern	al clock may be applied at the	FXT input	
Time/Division Range	HD1024 on: 20 ps/div - 500		lai clock may be applied at the		
Time, Division Hunge	HD1024 off: 20 ps/div - 6.4	s/div:			
	RIS available at ≤ 10	ns/div;			
Clock Accuracy	Roll Mode available a $1.5 \text{ ppm} +(\text{aging of } 0.5 \text{ ppm})$	$t \ge 100 \text{ ms/div and} \le 5 \text{ MS/s}$			
Clock Accuracy Channel-Channel Deskew Range	±9 x time/div. setting, each c				
External Timebase Reference (Input)					
External Timebase Reference (Output)		nchronized to reference bein	g used by user (internal or exte	ernal reference)	
External Clock	DC to 100 MHz; (50 $\Omega$ /1 M $\Omega$ ), Ext. BNC input, Minimum rise time and amplitude requirements apply at low frequencies				
	Minimum rise time and amp	litude requirements apply at	low trequencies		
<b>Acquisition - Analog Channels</b>					
Sample Rate (Single-Shot)	20 GS/s on 4 Ch; 40 GS/s or	12 Ch			
Sample Rate (Repetitive)	200 GS/s for repetitive signals (20 ps/div to 10 ns/div)				
Memory Length (4 Ch / 2 Ch )	64M / 128M	· · · · · · · · · · · · · · · · · · ·			
(Number of Segments)	(15,000)				
Intersegment Time	1 µs				
Averaging Envelope (Extrema)		ion sweeps; continuous avera	aging to 1 million sweeps		
Envelope (Extrema)	Envelope floor or roof for ur	to I million sweeps			

\* When used with PP022 passive probe.

\*\* Measured at half-bandwidth point, 100 mV/div, 90% full scale.

Envelope, floor, or roof for up to 1 million sweeps

Linear or Sin x/x (2 pt and 4 pt); automatically set when HD1024 is enabled

+ Measured with HD1024 enabled.

	HDO9104 HDO9104-MS	HD09204 HD09204-MS	HD09304 HD09304-MS	HDO9404 HDO9404-MS
Vertical, Horizontal, Acquisition	- Digital Channels (-MS Mo	dels only)		
Maximum Input Frequency	250 MHz			
Minimum Detectable Pulse Width	2 ns			
nput Dynamic Range	± 20V			
nput Impedance (Flying Leads)	100 kΩ    5 pF			
nput Channels Jaximum Input Voltage	<u>16 Digital Channels</u> ±30V Peak			
Ainimum Input Voltage Swing	400mV			
Threshold Groupings	Pod 2: D15 - D8, Pod 1: D7 - D	00		
Threshold Selections	TTL, ECL, CMOS (2.5 V, 3.3 V,		fined	
Threshold Accuracy	$\pm(3\% \text{ of threshold setting} + 1)$	00mV)		
Jser Defined Threshold Range	±10 V in 20 mV steps			
Jser Defined Hysteresis Range Sample Rate	<u>100 mV to 1.4 V in 100 mV ste</u> 1.25 GS/s	ps		
Record Length	128MS - 16 Channels			
Channel-to-Channel Skew	350 ps			
Triggering System	Numeral Austra Oireada avail Ota			
Modes Sources	Normal, Auto, Single, and Sto		gue to each source (except lin	e triager)
Coupling	DC, AC, HFRej, LFRej	<u>ט, טר ווווב, אוטףב מדוע ופעפו ערוונ</u>	קטב נט במנוז שטטוניב (פגניבטן וווו	
Pre-trigger Delay	0 - 100% of memory size (ad	justable in 1% increments or	100 ns)	
Post-trigger Delay	0 - 10,000 divisions in real tir	ne mode, limited at slower ti	me/div settings or in roll mod	e
Hold-off	From 2 ns up to 20 s or from		-	
Internal Trigger Level Range	±4.1 div from center (typical)			
External Trigger Level Range	Ext (±0.4 V); Ext/10 (±4 V)	dia Demonstra Maria and	<b>A</b> - [ ] - )	
Maximum Trigger Rate Trigger Sensitivity with Edge Trigger	1,000,000 waveforms/secon 2 div @ < 1 GHz	<u>a (in Sequence Mode, up to -</u> 2 div @ < 2 GHz	2 div @ < 3 GHz	2 div @ < 4 GHz
Ch $1-4$ )	1.5 div @ < 500 MHz	1.5 div @ < 1 GHz	1.5 div @ < 1.5 GHz	1.5 div @ < 2 GHz
	1 div @ < 200 MHz	1 div @ < 200 MHz	1 div @ < 200 MHz	1 div @ < 200 MHz
	0.9 div @ < 10 MHz	0.9 div @ < 10 MHz	0.9 div @ < 10 MHz	0.9 div @ < 10 MHz
	(DC, AC, and LFRej coupling)	(DC, AC, and LFRej coupling)	(DC, AC, and LFRej coupling)	(DC, AC, and LFRej coupling)
External Trigger Sensitivity,	2 div @ 1 GHz	Er nej coupinig)	Li nej coupiing)	Er nej coupling)
(Edge Trigger)	1.5 div @ < 500 MHz			
	1 div @ < 200 MHz			
	0.9 div @ < 10 MHz			
Max. Trigger Frequency,	(DC, AC, and LFRej coupling) 1 GHz @	2 GHz @	2 GHz @	2 GHz @
SMART Trigger	≥ 10 mV/div	≥ 10 mV/div	≥ 10 mV/div	≥ 10 mV/div
	(minimum triggerable	(minimum triggerable	(minimum triggerable	(minimum triggerable
	width 750 ps)	width 400 ps)	width 270 ps)	width 200 ps)
Trigger Types				
Edge	Triggers when signal meets s	slone (nositive negative or e	ither) and level condition	
Vidth			ctable as low as 500 ps (depe	nding on oscilloscope band
	<u>width) to 20 s, or on intermitt</u>	ent faults		
Glitch	Triggers on positive or negat width) to 20 s, or on intermitt	ive glitches with widths selection	ctable as low as 200 ps (depe	nding on oscilloscope band
Window	Triggers when signal exits a		e thresholds	
Pattern			channels and external trigger i	nput. Each source can be
	high, low, or don't care. The H	ligh and Low level can be se	lected independently. Triggers	at start or end of the patter
TV-Composite Video	Triggers NTSC or PAL with se	electable line and field;		
	HDTV (720p, 1080i, 1080p) v	with selectable frame rate (50 $d_{2}$ (1-8) Lines (up to 2000)	) or 60 Hz) and Line; or Frame Pates (25, 20, 50, or 6	
	Interlacing (1:1, 2:1, 4:1, 8:1).	or Synch Pulse Slope (Positi	, Frame Rates (25, 30, 50, or 6 ve or Negative)	0 112),
Runt	Trigger on positive or negativ	e runts defined by two volta	ge limits and two time limits.	
- •	Select between 1 ns and 20 ns			
Slew Rate			<u>Select edge limits between 1 n</u>	s and 20 ns
nterval	Triggers on intervals selectal		hotween 1 no and 20 a	
Dropout Exclusion Triggering	Triggers if signal drops out fo		between 1 ns and 20 s behavior and triggering when	that condition is not mot
Aeasurement Trigger	Trigger on measurement value			
Aulti-stage: Qualified	Triggers on any input source	only if a defined state or edd	ge occurred on another input s	source.
	Delay between sources is sel	ectable by time or events	· ·	
	In Sequence acquisition mode, triggers repeatably on event B only if a defined pattern, state, or edge (event A) is satisfied in the first segment of the acquisition. Holdoff between sources is selectable by time or events			
Multi-stage: Qualified First	satisfied in the first segment	of the acquisition Holdoff h	etween sources is selectable	by time or events



SPECIFICATIO	NS			HD
				1024
	HDO9104 HDO9104-MS	HDO9204 HDO9204-MS	HD09304 HD09304-MS	HD09404 HD09404-MS
Trigger Types (cont'd)				
Multi-stage: Cascade (Sequence)	Cascade A then B: Edge, Wind	ow. Pattern (Logic) Width. Glitcl	h, Interval, Dropout, or Measurer	ment. Measurement can be on
Trigger, Types	Stage B only. Cascade A then B then C (Mea Measurement. Measurement of Cascade A then B then C: Edge	isurement): Edge, Window, Patt can be on Stage C only. e, Window, Pattern (Logic).	tern (Logic), Width, Glitch, Interva	al, Dropout, or
Multi-stage: Cascade (Sequence) Trigger, Holdoff	Holdoff between A and B. B a	and C, C and D is selectable by on as the last stage in a Casc	y time (1ns to 20s) or number ade precludes a holdoff settin	of events.
<b>Optional High-speed Serial Prote</b>	ocol Triggering (HDO9K-80	B-8B10B TD)		
Data Rates	150 Mb/s-3.125 Gb/s			
Pattern Length	80-bits, NRZ or 8b/10b			
Clock Recovery Jitter	1 ps <sub>rms</sub> + 0.3% Unit Interval F	RMS for PRBS data patterns v	with 50% transition density	
Hardware Clock Recovery Loop BW	PLL Loop BW = Fbaud/5500			
5 1			,	
Display System	Color 15 4" widocorrest	aitiva tauah aaraar		
<u>Size</u> Resolution	Color 15.4" widescreen capa WXGA; 1280 x 800 pixels	CILIVE LOUCH SCREEN		
Number of Traces		and Cincultaneously display	channel, zoom, memory and n	
Grid Styles	Auto Single Dual Quad Oct	al X V Single+X V Dual+X V T	andem, Quatro, Twelve, Sixtee	
Waveform Representation	Sample dots joined, or samp		andern, Quatro, Twelve, Sixtee	
Processor/CPU	Sample dots joined, or samp			
	Intel® i5-3610 Dual Core, 2.7	CLIZ (or bottor)		
<u>Type</u> Processor Memory	16 GB standard	GHZ (OF DELLET)		
Operating System	Microsoft Windows® 7 For E	mbedded Systems 64Bits		
Real Time Clock	Date and time displayed with	waveform in hardcopy files. S	NTP support to synchronize to	precision internal clocks
Connectivity				
Ethernet Port	Supports 10/100/1000Base	T Ethernet interface (B 1/15 p	ort)	
USB Host Ports	4 side USB 3.1 Gen1 ports 2	side USB 2.0 ports and 1 fro	nt USB 2.0 port support Winde	ows compatible devices
USB Device Port	1 port - USBTMC over USB 3	1 Gen1		
GPIB Port (Optional)	Supports IEEE-488.2 (Extern			
External Monitor Port	2 full-size DisplayPort conne	ctors and 1 DVI-D		
	Includes support for extende	d desktop operation with WX	GA resolution on second mon	itor
Remote Control	Via Windows Automation, or		Command Set	
Network Communication Standard Peripheral Bus	VXI-11 or VICP, LXI Class C (N Teledyne LeCroy LBUS stand			
Power Requirements	, ,			
Voltage	100-240 VAC ±10% at 50/60	) Hz ±5%; 100-120 VAC ±109	% at 400 Hz ±5%;	
-	Automatic AC Voltage Select	tion; Installation Category: 30		
Nominal Power Consumption Max Power Consumption	415 W / 415 VA	paripharala activa prohas por	nnected to 4 channels, and MS	20 pativo)
	500 W / 500 VA (with all PC)	periprierais, active probes cor	inected to 4 channels, and Ms	so active)
Environmental				
Temperature (Operating)	+5 °C to +40 °C			
Temperature (Non-Operating)	-20 °C to +60 °C			
Humidity (Operating)	5% to 90% relative humidity (	(non-condensing) up to +31 °( elative humidity (Non-condension)	$C_{\rm sing}$ at $\pm 40$ °C	
Humidity (Non-Operating)		non-condensing) as tested p		
Altitude (Operating)	Up to 3.000 m at or below +3			
Altitude (Non-Operating)	Up to 40,000 ft. (12,192 m)			
Random Vibration (Operating)	0.31 g <sub>rms</sub> 5 Hz to 500 Hz, 15	minutes in each of three orth	logonal axes	
Random Vibration (Non-Operating)	2.4 g <sub>rms</sub> 5 Hz to 500 Hz, 15 n	ninutes in each of three ortho	gonal axes	
Functional Shock	30 g <sub>peak</sub> , half sine, 11 ms pulse,	3 shocks (positive and negative	e) in each of three orthogonal axe	es, 18 shocks total
Size and Weight				
Dimensions (HWD)	14.1" H x 17.5" W x 9.5" D (35	<u>68 x 445 x 242 mm)</u>		
Weight	25.8 lbs. (11.7 kg)	,		
Certifications	,			
CE Certification	CE Compliant LIL and cl.II. lic	ted: Conforms to LIL 61010 1	I (3rd Edition), UL 61010-2-030	) (1st Edition)
UL and cUL Listing	CAN/CSA C22.2 No. 61010-1		1 (314 LUIUOH), OL 01010-2-030	
Warranty and Service				
-	3-year warranty; calibration r upgrades, and calibration ser	ecommended annually. Optic rvices	nal service programs include	extended warranty,



#### Standard

#### Math Tools

Display up to 12 math function traces (F1-F12). The easy-to-use graphical interface simplifies setup of up to two operations on each function trace, and function traces can be chained together to perform math-on-math.

#### **Measure Tools**

Display any 12 parameters together with statistics, including their average, high, low, and standard deviations. Histicons provide a fast, dynamic view of parameters and wave shape characteristics. Parameter Math allows addition, subtraction, multiplication, or division of two different parameters.

amplitude	level @ x	rms
area	maximum	std. deviation
base	mean	top
bit rate	median	width
cycles	minimum	phase
delay	narrow band phase	time @ minimum (min.)
∆ delay	narrow band power	time @ maximum (max.)
duty cycle	number of points	$\Delta$ time @ level
duration	+ overshoot	$\Delta$ time @ level from
falltime (90–10%,	– overshoot	trigger
80–20%, @ level)	peak-to-peak	x @ max.
frequency	period	x @ min.
first	risetime (10–90%,	
last	20-80%, @ level)	

#### Pass/Fail Testing

Simultaneously test multiple parameters against selectable parameter limits or pre-defined masks. Pass or fail conditions can initiate actions including document to local or networked files, e-mail the image of the failure, save waveforms, send a pulse out at the front panel auxiliary BNC output, or (with the GPIB option) send a GPIB SRQ.

#### Standard (cont'd)

#### Basic Jitter and Timing Analysis

This package provides jitter timing and analysis using time, frequency, and statistical views for common timing parameters, and also includes other useful tools. Includes:

- Width @ level

- Skew

- Duty Cycle @ level

- Duty Cycle Error

• "Track" graphs of all parameters, no limitation of number

- Hold

- N-Cycle
- Edge to Edge
  - e Time Interval Error @ level
- Frequency @ level Error (
- Period @ level
- Half Period
- Edge @ lv parameter (counts edges)
- Histograms expanded with 19 histogram parameters and up to 2 billion events
- Trend (datalog) of up to 1 million events
- Persistence histogram, persistence trace (mean, range, sigma)

#### **Software Options**

#### Advanced Customization (HDO9K-XDEV)

Provides capability to create a math function or measurement parameter in MATLAB, Excel, C++, JavaScript, or Visual Basic Script (VBS) format and insert it into the oscilloscope's processing stream. All results are processed and displayed on the oscilloscope grid, and are available for further processing. Also permits the creation of customized plug-ins that can be inserted into the scope user interface, control of the scope via Visual Basic scripts embedded in customized functions, and use of Teledyne LeCroy's Custom DSO capabilities.

#### SDA II Serial Data Analysis Option (HDO9K-SDAII)

#### Total Jitter

A complete toolset is provided to measure total jitter. Eye Diagrams with millions of UI are quickly calculated from up to 128 Mpts records, and advanced tools may be used on the Eye Diagram to aid analysis. Complete TIE and Total Jitter (Tj) parameters and analysis functions are provided.

- Time Interval Error (TIE) Measurement Parameter, Histogram, Spectrum and Jitter Track
- Total Jitter (Tj) Measurement Parameter, Histogram, Spectrum
- Eye Diagram Display (sliced)
- Eye Diagram IsoBER (lines of constant Bit Error Rate)
- Eye Diagram Mask Violation Locator
- Eye Diagram Measurement Parameters
- Eye Height
- One Level
- Zero Level
- Eye Crossing – Avg. Power

Eye Width

- Eye Amplitude
- Extinction Ratio
- Slice Width (setting)

- Mask hits

- Mask out

- Bit Error Rate

- Q-Fit Tail Representation
- Bathtub Curve
- Cumulative Density Function (CDF)
- PLL Track



#### Software Options (cont'd)

#### SDA II Serial Data Analysis Option (HDO9K-SDAII) - continued

#### Jitter Decomposition Models

Two jitter decomposition methods are provided and simultaneously calculated to provide maximum measurement confidence. Q-Scale, CDF, Bathtub Curve, and all jitter decomposition measurement parameters can be displayed using either method.

- Spectral Method
- NQ-Scale Method

#### Random Jitter (Rj) and Non-Data Dependent Jitter (Rj+BUj)

- Random Jitter (Rj) Measurement Parameter
- Ri+BUi Histogram
- Rj+BUj Spectrum
- Rj+BUj Track

#### Deterministic Jitter (Dj)

Deterministic Jitter (Dj) Measurement Parameter

#### Data Dependent Jitter (DDj)

- Data Dependent Jitter (DDj) Measurement Parameter
- DDj Histogram
- DDj Plot (by Pattern or N-bit Sequence)

#### Eye Doctor II Advanced Signal Integrity Tools (HD09K-EYEDRII)

Complete set of channel emulation, de-embedding and receiver equalization simulation tools. Provides capability to emulate a serial data link, de-embed or embed a fixture, cable or serial data channel, add or remove emphasis, and perform CTLE, FFE, or DFE equalization.

#### Power Analyzer Option (HD09K-PWR)

Power switching device measurements, control loop modulation analysis, and line power harmonic testing are all simplified with a dedicated user interface and automatic measurements.

Device Analysis

- Losses Automatic measurement of turn-on, turn-off, and conduction loses as well as off-state power, total losses and switching frequency
- Safe Operating Area
- B-H-Hysteresis Curve
- Dynamic On-Resistance
- Dv/dt and di/vt
- Control Loop Analysis
- Closed loop time-domain Duty cycle, width, period or frequency
- Line Power Analysis
- Power Vrms, Irms, real-power, apparent power, power factor, crest factor
- Harmonics EN61000-3-2 pre-compliance, Total Harmonic Distortion Measurement Setup
- Controls for Deskew, DC fine adjust, probe integration, device zone identification

#### Cable De-embedding Option (HDO9K-CBL-DE-EMBED)

Removes cable effects from your measurements. Simply enter the S-parameters or attenuation data of the cable(s) then all of the functionality of the HDO9K can be utilized with cable effects de-embedded.

#### 8b/10b Decode and 80-bit High Speed Serial Trigger Option (HD09K-80B-8B10B TD)

Intuitive, color-coded serial trigger decode with powerful search capability enables captured waveforms to be searched for user-defined sequences of symbols. Multi-lane analysis decodes up to four simultaneously captured lanes. Includes 150 Mb/s to 3.125 Gb/s High-speed 80-bit Serial Pattern Trigger Option

#### Software Options (cont'd)

#### Serial Data Mask Option (HDO9K-SDM)

Create eye diagrams using a comprehensive list of standard eye pattern masks, or create a user-defined mask. Mask violations are clearly marked on the display for easy analysis.

#### Electrical Telecom Pulse Mask Test Option (HD09K-ET-PMT)

Performs automated compliance mask tests on a wide range of electrical telecom standards.

#### Spectrum Analyzer Option (HD09K-SPECTRUM)

- Spectrum analyzer style user interface and advanced FFT capabilities.
- Automatic oscilloscope setup when selecting start/stop frequency or center frequency and span
- Resolution bandwidth automatically or manually controlled
- FFT Reference and vertical scale in dBm, dBV, dBmV, dBuV, Vrms or Arms
- Spectrogram provides 2D or 3D spectral history display
- Up to 100 automatic peak markers
- Up to 20 markers, either manually controlled or automatic which mark fundamental frequency and harmonics
- Math waveform analysis, additional output types:
  - Power density
- Real
- Imaginary
- Magnitude squared

#### Disk Drive Measurements Option (HDO9K-DDM2)

This package provides disk drive parameter measurements and related mathematical functions for performing disk drive WaveShape Analysis.

- Disk Drive Parameters are as follows:
- amplitude
- asymmetry
- local base
- local baseline
- separation
- local maximum
- local minimum
- local number
- local peak-peak
- local time
- between events local time
- between peaks
- between troughs

- local time at minimum
- local time
- at maximum
- peak-trough
- over threshold
- trough-peak
- local time
- - non-linear transition shift

- overwrite

- resolution

- track average

- track average

amplitude -

track average

amplitude +

- auto-correlation s/n

amplitude

- pulse width 50

24

- pulse width 50 -- pulse width 50 +
- local time
- local time
- local time

- under threshold
- narrow band phase
- narrow band power

local time

## **ORDERING INFORMATION**

Product Description	Product Code
HD09000 Oscilloscopes	
1 GHz, 10-bit, 20 GS/s, 4ch, 64 Mpts/Ch	HD09104
High Definition Oscilloscope	
with 15.4" WXGA capacitive touch screen.	
40 GS/s, 128 Mpts/Ch in interleaved mode.	
2 GHz, 10-bit, 20 GS/s, 4ch, 64 Mpts/Ch	HD09204
High Definition Oscilloscope	
with 15.4" WXGA capacitive touch screen.	
40 GS/s, 128 Mpts/Ch in interleaved mode.	
3 GHz, 10-bit, 20 GS/s, 4ch, 64 Mpts/Ch	HD09304
High Definition Oscilloscope	
with 15.4" WXGA capacitive touch screen.	
40 GS/s, 128 Mpts/Ch in interleaved mode.	
4 GHz, 10-bit, 20 GS/s, 4ch, 64 Mpts/Ch	HD09404
High Definition Oscilloscope with 15.4" WXGA	
capacitive touch screen.	
40 GS/s, 128 Mpts/Ch in interleaved mode.	
1 GHz, 10-bit, 20 GS/s, 4ch, 64 Mpts/Ch	HD09104-MS
High Definition Mixed Signal Oscilloscope	
with 15.4" WXGA capacitive touch screen.	
40 GS/s, 128 Mpts/Ch in interleaved mode.	
2 GHz, 10-bit, 20 GS/s, 4ch, 64 Mpts/Ch	HD09204-MS
High Definition Mixed Signal Oscilloscope	
with 15.4" WXGA capacitive touch screen.	
40 GS/s, 128 Mpts/Ch in interleaved mode.	
3 GHz, 10-bit, 20 GS/s, 4ch, 64 Mpts/Ch	HD09304-MS
High Definition Mixed Signal Oscilloscope	
with 15.4" WXGA capacitive touch screen.	
40 GS/s, 128 Mpts/Ch in interleaved mode.	HD09404-MS
4 GHz, 10-bit, 20 GS/s, 4ch, 64 Mpts/Ch	HD09404-1015
High Definition Mixed Signal Oscilloscope	
with 15.4" WXGA capacitive touch screen. 40 GS/s, 128 Mpts/Ch in interleaved mode.	
40 00/5, 120 Mpts/01111 Interieaved 11008.	

#### Product Description

#### Included with Standard Configurations (HDO9000 and HDO9000-MS)

 $\div10,500$  MHz Passive Probe (Qty. 4), Protective Cover, Getting Started Guide, Anti-virus Software (Trial Version), Microsoft Windows® 7 For Embedded Systems 64Bits, Commercial NIST Traceable Calibration with Certificate, Power Cable for the Destination Country, 3-year Warranty

#### Included with HDO9000-MS

16 Channel Digital Leadset, Extra Large Gripper Probe Set (Qty. 22), Ground Extenders (Qty. 20), Flexible Ground Leads (Qty. 5)

#### **Computer Upgrade**

oompater opgraae	
256 GB Removable Solid State Drive Option	HD09K-256GB-RSSD
Additional 256 GB Solid State Drive for	HDO9K-256GB-RSD-02
use with RSSD option. Includes Microsoft	
Windows® 7 For Embedded Systems 64Bits,	
Teledyne LeCroy Oscilloscope Software and	
Critical Scope Operational File Duplicates.	
High-speed Digital Analyzer Systems	
12.5 GS/s High-speed Digital Analyzer with	HDA125-18-LBUS
18ch QuickLink leadset and LBUS connection	
12.5 GS/s High-speed Digital Analyzer with	HDA125-09-LBUS
9ch QuickLink leadset and LBUS connection	

#### Oscilloscope Synchronization

Hardware kit to allow for 8 channel synch capability to combine 2 HDO9000 High Definition Oscilloscopes



Product Code

## ORDERING INFORMATION

Product Description	Product Code
Serial Trigger and Decode	
MIL-STD-1553 Trigger and Decode Option	HD09K-1553 TD
MIL-STD-1553 Trigger, Decode, Measure/	
Graph, and Eye Diagram Option	
8b10b Decode Option- Includes 80 bit	HD09K-80B-8b10b TD
3.125 Gb/s serial trigger	
AudioBus Trigger and Decode Option	HD09K-Audiobus TD n HD09K-Audiobus TDG
AudioBus trigger, decode, and graph Optic ARINC 429 Bus Symbolic HD09	K-ARINC429BUS DSYMBOLIC
Decode Option	CARING429B03 D31WB0EIC
	NC429BUS DME SYMBOLIC
Decode, Measure/Graph,	
and Eye Diagram Option	
CAN FD Trigger and Decode Option	HD09K-CAN FDBUS TD
CAN FD Trigger, Decode, Measure/	HD09K-CAN FDBUS TDME
Graph, and Eye Diagram Option	
CAN FD Symbolic Trigger, HD09K-C Decode, and Measure/Graph,	AN FDBUS TDME SYMBOLIC
and Eye Diagram Option	
CAN Trigger & Decode Option	HD09K-CANBUS TD
CAN Trigger, Decode, Measure/Graph,	HD09K-CANBUS TDME
and Eye Diagram Option	
	K-CANBUS TDME SYMBOLIC
Decode, and Measure/Graph,	
and Eye Diagram Option	
DigRF 3G Bus Decode Option	HD09K-DigRF3Gbus D
DigRF V4 Bus Decode Option MIPI D-PHY CSI-2, DSI Bus Decode Option	HD09K-DigRFV4bus D
MIPI D-PHY CSI-2, DSI Bus Decode Option MIPI D-PHY CSI-2, DSI Bus Decode and	HD09K-DPHYbus D HD09K-DPHYbus DP
Physical Layer Test Option	HDO9R-DEHTDOS DE
ENET Bus Decode Option	HD09K-ENETbus D
Bundle: Includes I2C, SPI, UART-RS232	HD09K-EMB TD
Trigger and Decode Option	
Bundle: Incl. I2C, SPI, UART-RS232	HD09K-EMB TDME
Trigger, Decode, Measure/Graph, and	
Eye Diagram Option	
FibreChannel decode annotation Option	HD09K-FCbus D HD09K-FLEXRAYBUS TD
FlexRay Trigger and Decode Option FlexRay Trigger, Decode, Measure/	HD09K-FLEXRAYBUS TDMP
Graph and Physical Layer Option	HDU9R-FLEXATBUS IDMP
I2C Trigger and Decode Option	HD09K-I2CBUS TD
I2C Trigger, Decode, Measure/Graph,	HD09K-I2CBUS TDME
and Eye Diagram Option	
LIN Trigger and Decode Option	HD09K-LINBUS TD
LIN Trigger, Decode, Measure/Graph,	HD09K-LINBUS TDME
and Eye Diagram Option	
Manchester Bus Decode Option	HD09K-MANCHESTERbus D
MIPI M-PHY Bus Decode Option	HD09K-MPHYbus D
MIPI M-PHY Bus Decode and Physical Layer Test Option	HD09K-MPHYbus DP
NRZ Bus Decode Option	HD09K-NRZbus D
PCIe Gen 1 Decode Option	HD09K-PClebus D
Serial Debug Toolkit - Measure Analyze	HD09K-PROTOBUS MAG
Graph Option	
Decode Annotation and Protocol	HD09K-ProtoSync
Analyzer Synchronization Option	
Decode Annotation and Protocol Analyze	r+Bit HD09K-ProtoSync-BT
Tracer Synchronization Option	
SAS Decode annotation Option	HD09K-SASbus D
SATA Trigger and Decode Option	HD09K-SATAbus TD
SENT Bus Decode Option SpaceWire Decode Option	HD09K-SENTbus D HD09K-SPACEWIREbus D
ομασείνητε μεσομε ομποιη	HDUSIN-SPACEWIKEDUS D

#### **Product Description**

Serial Trigger and Decode (con	ťd)
SPI Trigger and Decode Option	HD09K-SPIBUS TD
SPI Trigger, Decode, Measure/Graph	n, HD09K-SPIBUS TDME
and Eye Diagram Option	
UART-RS232 Trigger and Decode Op	tion HD09K-UART-RS232BUS TD
UART-RS232 Trigger, Decode,	HD09K-UART-RS232BUS
Measure/Graph, and Eye Diagram Opt	tionTDME
MIPI UniPro Protocol Decoder Softw	vare Option HDO9K-UNIPRObus D
MPHY to UniPro Decoder	HD09K-UPG-MPHY-UNIPRObus D
Software Upgrade	
MPHY REQUIRED	
USB 2.0 HSIC Decode Option	HD09K-USB2-HSICbus D
USB 2.0 Trigger and Decode Option	HD09K-USB2BUS TD
USB 2.0 Trigger, Decode, Measure/	HD09K-USB2BUS TDME
Graph, and Eye Diagram Option	

Product Code

#### Serial Data Compliance

QualiPHY Enabled BroadR-Reach	QPHY-BroadR-Reach
Software Option	
QualiPHY Enabled Ethernet 10/100/1000BT	QPHY-ENET*
Software Option	
QualiPHY Enabled DDR2 Software Option	QPHY-DDR2
QualiPHY Enabled DDR3 Software Option	QPHY-DDR3
QualiPHY Enabled LPDDR2 Software Option	QPHY-LPDDR2
QualiPHY Enabled MIPI D-PHY Software Option	QPHY-MIPI-DPHY
QualiPHY Enabled MOST150Software Option	QPHY-MOST150
QualiPHY Enabled MOST50 Software Option	QPHY-MOST50
QualiPHY Enabled USB 2.0 Software Option	QPHY-USB ‡
10/100/1000Base-T Ethernet Test Fixture	TF-ENET-B**
USB 2.0 Compliance Test Fixture	TF-USB-B

\* TF-ENET-B required. ‡ TF-USB-B required. \*\* Includes ENET-2CAB-SMA018 and ENET-2ADA-BNCSMA.

#### Serial Data Analysis

Cable De-Embedding Option	HD09K-CBL-DE-EMBED
Eye Doctor (Virtual Probe and Equalizer	HD09K-EYE-
Emulation Bundle)	DRII
Serial Data Mask Software Option	HD09K-SDM
SDAII Serial Data Analysis Option	HD09K-SDAII

#### DDR Debug Toolkits

DDR2 and LPDDR2 Debug Toolkit	HD09K-DDR2-TOOLKIT
DDR3, DDR3L, LPDDR3, DDR2, and	HD09K-DDR3-TOOLKIT
LPDDR2 Debug Toolkit	
DDR3, DDR3L, LPDDR3, DDR2, and	HD09K-UPG-DDR3-T00LKIT
LPDDR2 Debug Toolkit Upgrade	

## **ORDERING INFORMATION**

Product Description	Product Code
Data Storage Software	
Advanced Optical Recording Measurement Packag Disk Drive Measurements Software Package	
Disk Drive Analyzer Software Package	HD09K-DDM2 HD09K-DDA
blok brive Analyzer bortware i dokage	HB05K BBK
Power Analysis Software	
Power Analyzer Software Option	HD09K-PWR
Modulated Signal Analysis	
VectorLinQ – Flexible vector signal analysis for H	D09k-VECTORLINQ
electrical signals (RF and baseband I-Q)	
Jitter Analysis Software	
Clock, Clock-Data Jitter Analysis And Views Of Time	e, HDO9K-JITKIT
Statistical, Spectral, and Jitter Overlay	
Other Software Ontions	
Other Software Options Advanced Customization Option	HD09K-XDEV
EMC Pulse Parameter Software Option	HD09K-EMC
Electrical Telecom Mask Test Software Option	HD09K-ET-
	PMT
Q-Scape Multi-tab Display Option	HD09K-Q-SCAPE
Spectrum Analyzer and Advanced FFT Option	HD09K-SPECTRUM
Digital Filtering Software	
Digital Filter Software Option	HD09K-DFP2
Remote Control/Network Options	
External USB2 to GPIB Adaptor	USB2-GPIB
General Accessories	
Oscilloscope Cart with Additional Shelf and Drawer	
Oscilloscope Cart	OC1021 HD09K-RACK
Rackmount, 8U Adaptor Kit Keyboard, USB	KYBD-1
Soft Carrying Case	HD09K-SOFTCASE
Probes	
500 MHz Passive Probe, 2.5mm, 10:1, 10 MΩ	PP022
500 MHz Passive Probe, 5mm, 10:1, 10 MΩ	PP024
<u>1 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe</u> Set of 4 ZS1000, 1 GHz, 0.9 pF.	ZS1000 ZS1000-OUADPAK
$1 M\Omega$ High Impedance Active Probe	231000-QUADFAR
1.5 GHz, 0.9 pF, 1 M $\Omega$ High Impedance Active Probe	
Set of 4 ZS1500, 1.5 GHz, 0.9 pF, <u>1 MΩ High Impedance Active Probe</u>	ZS1500-QUADPAK
2.5 GHz, 0.9 pF, 1 M $\Omega$ High Impedance Active Probe	e ZS2500
Set of 4 ZS2500, 2.5 GHz, 0.9 pF,	ZS2500-QUADPAK
1 MΩ High Impedance Active Probe 4 GHz, 0.6 pF, 1 MΩ High Impedance Active Probe	ZS4000
$200 \text{ MHz}$ , $3.5 \text{ pF}$ , $1 \text{ M}\Omega$ Active Differential Probe, $\pm 2$	
500 MHz, 1.0 pF Active Differential Probe, ±8 V	ZD500
1 GHz, 1.0 pF Active Differential Probe, ±8 V	ZD1000
1.5 GHz, 1.0 pF Active Differential Probe, ±8 V	ZD1500
500 MHz, Active Differential Probe (÷1, ÷10, ÷100)	AP033



#### **Product Description**

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Probes (cont'd)	
WaveLink 4 GHz, 2.5 Vp-p Differential Probe System	D410-PS
WaveLink 4 GHz, 5 Vp-p Differential Probe System	D420-PS
WaveLink 4 GHz Differential Amplifier Module	D400A-AT*
with Adjustable Tip	
WaveLink ProBus Platform/Cable Assembly (4 GHz)	WL-PBus-CASE
1 Ch, 100 MHz Differential Amplifier	DA1855A
with Precision Voltage Source	
DA1855A with Rackmount	DA1855A-RM
2 Ch, 100 MHz Differential Amplifier with Precision Voltage Source	DA1855A-PR2
DA1855A with Rackmount (must be ordered at time of purchase, no retrofit)	DA1855A-PR2-RM
30 A; 50 MHz Current Probe – AC/DC; 30 Arms;	CP030
50 Apeak Pulse	
30A, 50 MHz High Sensitivity Current Probe - AC/DC, 30 A rms, 50 A Peak Pulse, 1.5 meter cable	CP030A
30 A; 100 MHz Current Probe – AC/DC; 30 Arms;	CP031
50 Apeak Pulse	CF 031
30A, 100 MHz High Sensitivity Current Probe -	CP031A
AC/DC, 30 A rms, 50 A Peak Pulse, 1.5 meter cable	CF031A
150 A; 10 MHz Current Probe – AC/DC;	CP150
150 Arms; 500 Apeak Pulse 500 A; 2 MHz Current Probe – AC/DC;	CP500
500 Arms; 700 Apeak Pulse	01 000
Deskew Calibration Source for CP031,CP031A, CP03C and CP030A	), DCS015
Programmable Current Sensor to ProBus Adapter for	CA10
use with third party current sensors	
Set of 4 CA10 Programmable Current Sensor to	CA10-QUADPAK
ProBus Adapters for third-party current sensors	
100:1 400 MHz 50 MΩ 1 kV High-voltage Probe	HVP120
100:1 400 MHz 50 MΩ 4 kV High-Voltage Probe	PPE4KV
1000:1 400 MHz 50 M $\Omega$ 5 kV High-Voltage Probe	PPE5KV
1000:1 400 MHz 5 MΩ / 50 MΩ 6 kV High-Voltage Pro	be PPE6KV
TekProbe to ProBus Probe Adapter	TPA10
Set of 4 TPA10 TekProbe to ProBus Probe Adapters. Includes soft carrying case	TPA10-QUADPAK
Optical-to-Electrical Converter, 500-870 nm ProBus	0E425
BNC Connector	02423
Optical-to-Electrical Converter, 950-1630 nm ProBus	OE455
BNC Connector	02400
1kV, 25 MHz High Voltage Differential Probe	HVD3102
1kV, 25 MHz High Voltage Differential	HVD3102-NOACC
Probe without tip Accessories	INDSTO2 NOAGE
1kV, 120 MHz High Voltage Differential Probe	HVD3106
1kV, 120 MHz High Voltage Differential Probe without tip Accessories	HVD3106-NOACC
2kV, 120 MHz High Voltage Differential Probe	HVD3206
2kV, 80 MHz High Voltage Differential Probe	HVD3206-6M
with 6m cable	
6kV, 100 MHz High Voltage Differential Probe	HVD3605
7.5 GHz Low Capacitance Passive Probe	PP066
(÷10, 1 kΩ; ÷20, 500 Ω)	

\* For a complete probe, order a WL-PBUS-CASE Platform/Cable Assembly with the Adjustable Tip Module





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1-800-5-LeCroy teledynelecroy.com Local sales offices are located throughout the world. Visit our website to find the most convenient location.

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